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**Braunisch**

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(54) **MATRIX MATCHING CROSSTALK REDUCTION DEVICE AND METHOD**

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**H03K 3/013** (2006.01)  
**H03K 19/00** (2006.01)

(52) **U.S. Cl.**  
CPC ..... **H03K 3/013** (2013.01); **H03K 19/0005** (2013.01)

(58) **Field of Classification Search**

USPC ..... 326/30  
See application file for complete search history.

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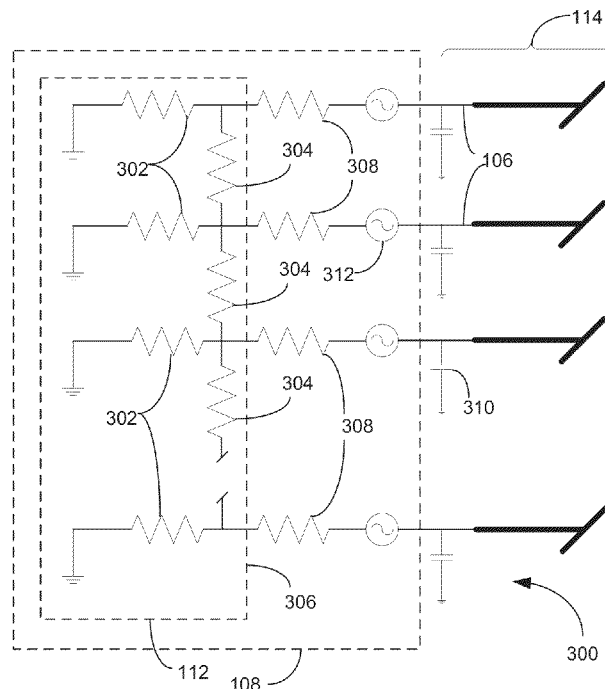
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(57) **ABSTRACT**

This disclosure relates generally to devices, systems, and methods that include conductive lines configured to transmit electrical signals between a first electronic component and a second electronic component between which the conductive lines are coupled. The devices, systems, and methods further include a transmitter, configured to generate the electrical signals, the transmitter including a source impedance based, at least in part, on a resistive coupling between individual ones of the conductive lines, a source impedance matrix of the source impedance being substantially proportional to the characteristic impedance matrix of the plurality of conductive lines.

**18 Claims, 5 Drawing Sheets**



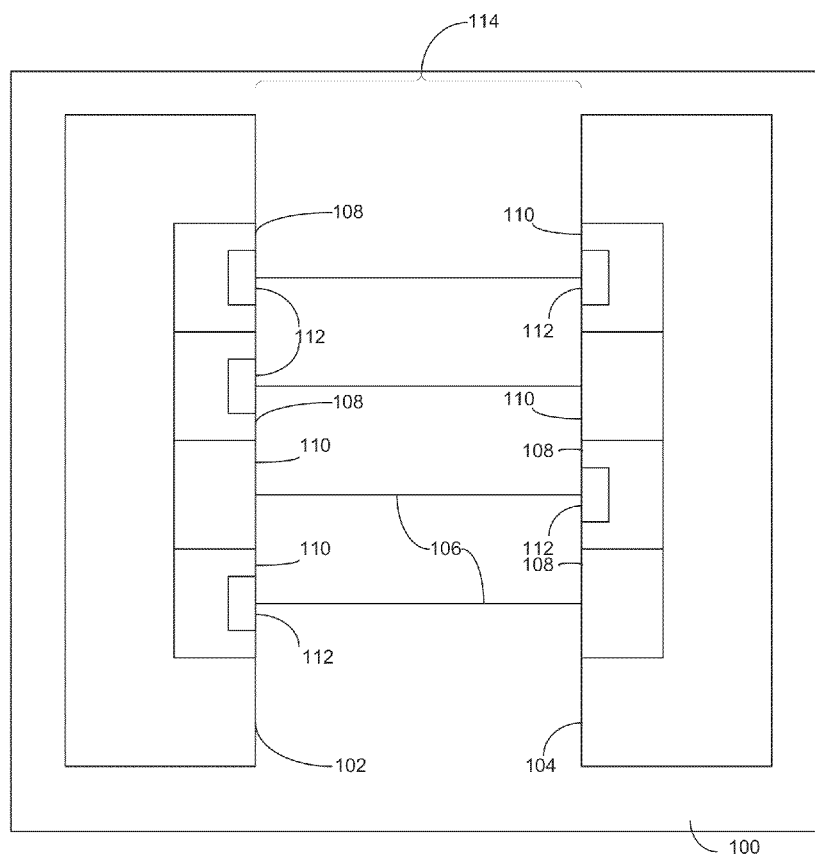


FIG. 1

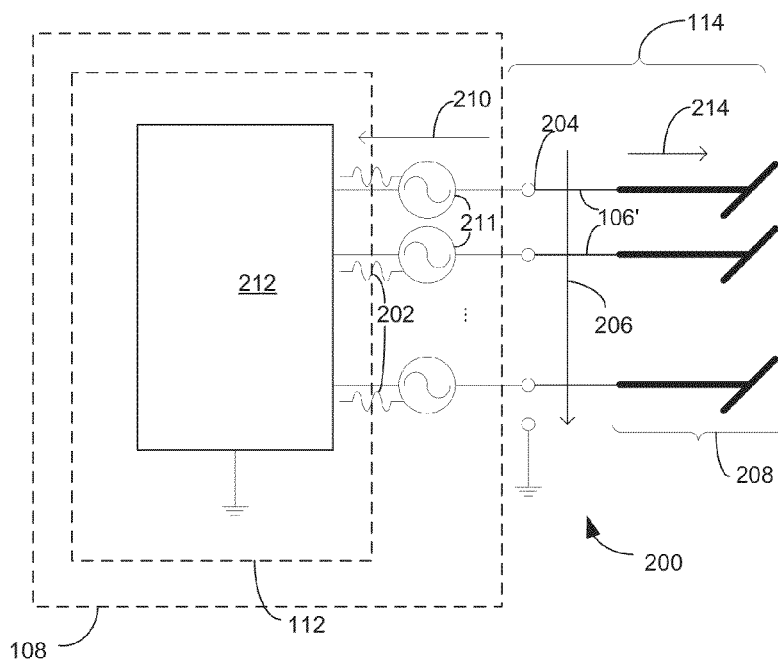


FIG. 2

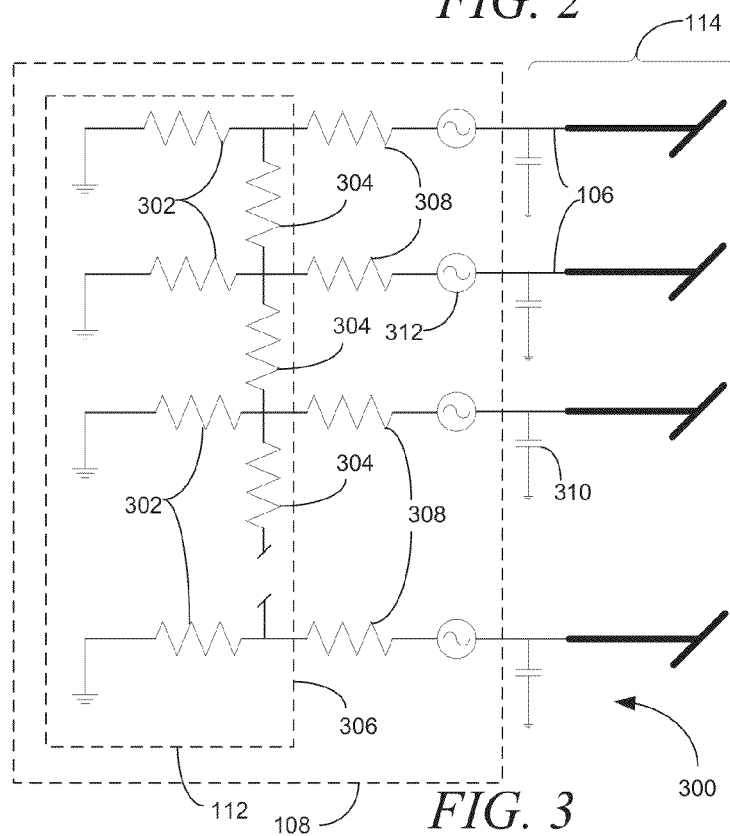
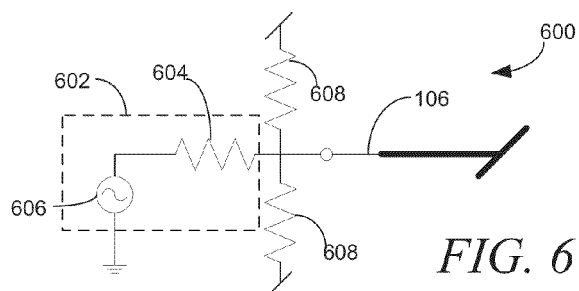
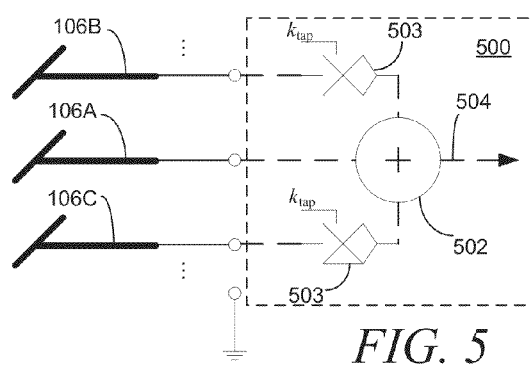
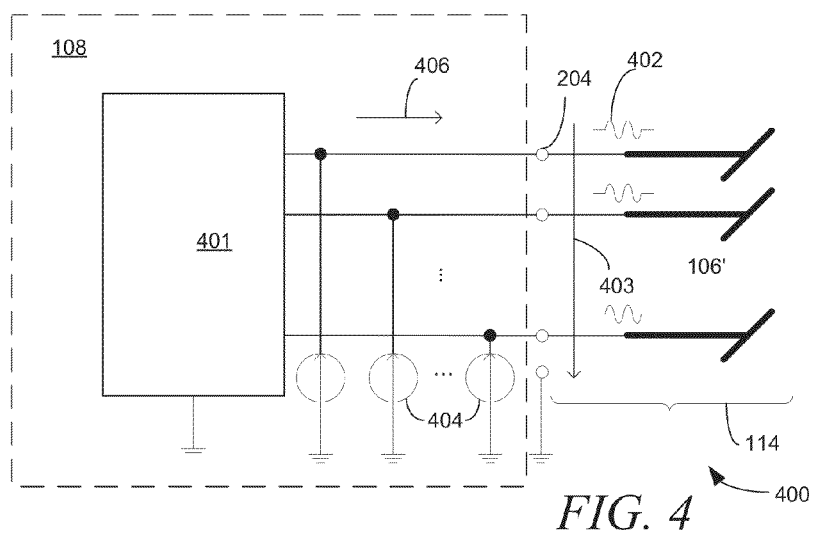
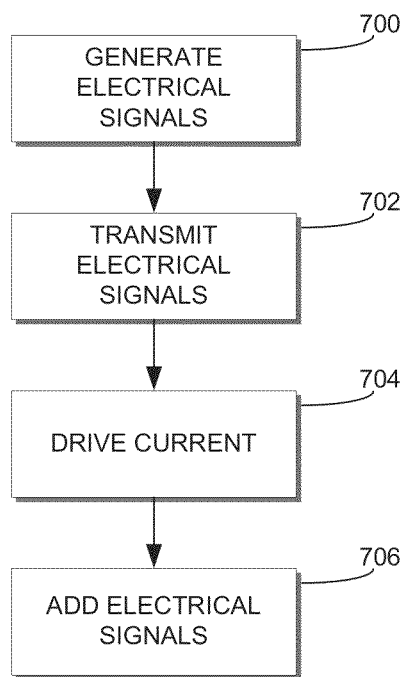


FIG. 3



*FIG. 7*

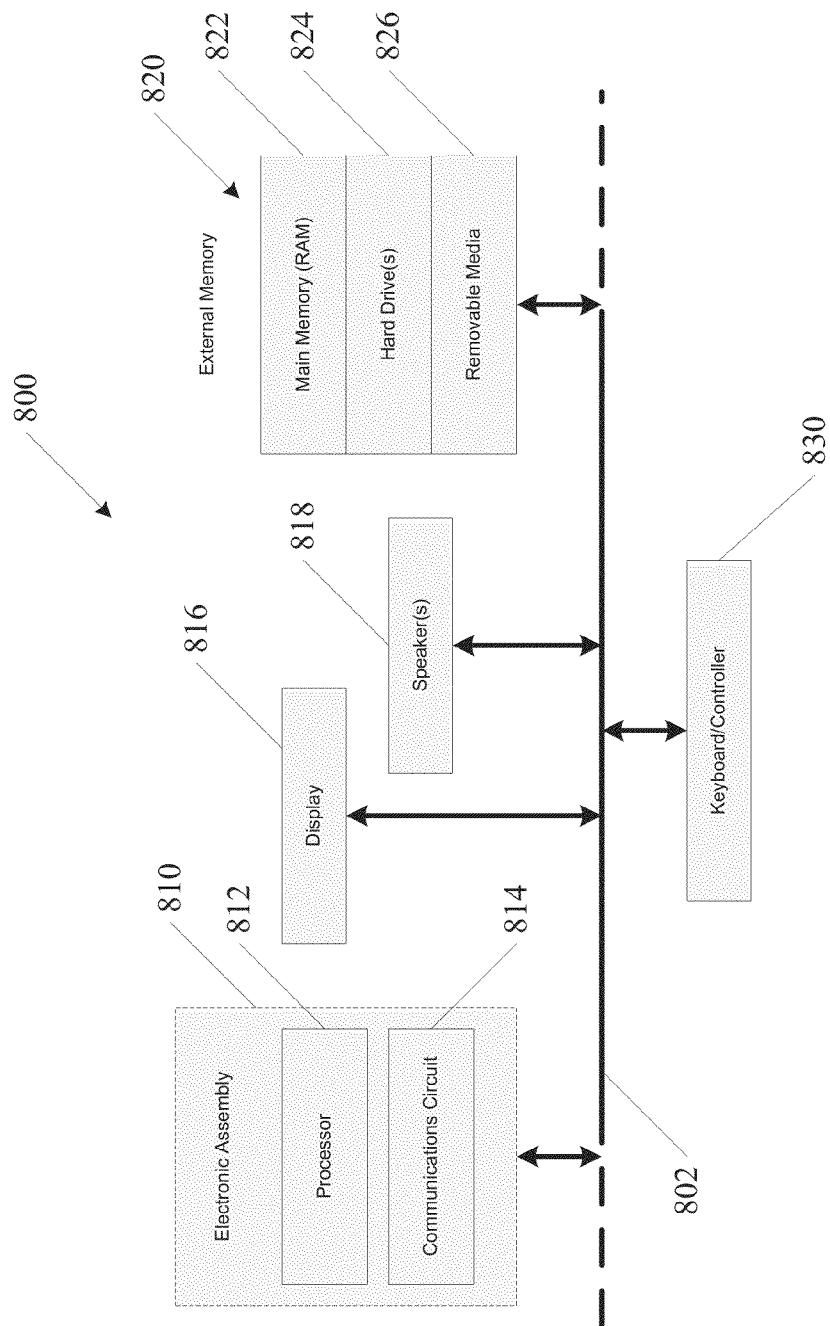


FIG. 8

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# MATRIX MATCHING CROSSTALK REDUCTION DEVICE AND METHOD

## TECHNICAL FIELD

The disclosure herein relates generally to a device and method for reducing crosstalk between conductive lines in an electronic circuit.

## BACKGROUND

Electronic circuits include conductive lines for the transmission of electrical signals between circuit components. Chip packages, printed circuit boards, and the like conventionally include conductive lines embedded in an insulator. Advances in technology have conventionally made such electronic circuits smaller and data rates higher. As the distance between conductive lines shrink, field effects may cause an electrical signal on one line to be manifested on a nearby line, a phenomenon known as crosstalk. Increases in data rates may exacerbate the effect of crosstalk by increasing a likelihood that such crosstalk may interfere with a signal on the nearby line.

## BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a simplified, cutaway, top profile of a chip package, in an example embodiment.

FIG. 2 is a circuit diagram of a circuit that includes a voltage signaling transmitter having a matching module, in an example embodiment.

FIG. 3 is a circuit diagram for a transmitter and conductive line, in an example embodiment.

FIG. 4 is a circuit diagram of a circuit that includes a current signaling transmitter having a matching module, in an example embodiment.

FIG. 5 is a circuit diagram of a matching module for a receiver tapping scheme for Norton formulation-based matrix matching, in an example embodiment.

FIG. 6 is a circuit diagram of a circuit including a voltage source for a transmitter, in an example embodiment.

FIG. 7 is a flowchart for transmitting electrical signals along a plurality of conductive lines, in an example embodiment.

FIG. 8 is a block diagram of an electronic device that can incorporate at least one package, in an example embodiment.

## DESCRIPTION OF EMBODIMENTS

The following description and the drawings sufficiently illustrate specific embodiments to enable those skilled in the art to practice them. Other embodiments may incorporate structural, logical, electrical, process, and other changes. Portions and features of some embodiments may be included in, or substituted for, those of other embodiments. Embodiments set forth in the claims encompass all available equivalents of those claims.

The bandwidth of conductive lines, such as between silicon dies in a chip package, can be scaled by increasing the signaling rate, the number of conductive lines, or both. Bandwidth scaling may become limited by crosstalk. When wave propagation is not purely transverse electromagnetic (TEM), due to a non-uniform dielectric background, such as for microstrip geometries or due to conductor loss, balancing of the capacitive and inductive coupling between lines can reduce crosstalk, such as by deliberately increasing the capacitive coupling. Such balancing may reduce transmission

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line far-end crosstalk (FEXT) at the expense of increased transmission line near-end crosstalk (NEXT). NEXT may be induced, at least in part, by parasitic capacitance in the circuit. Active FEXT cancellation may tend to increase total circuit components with a resultant increase in die and/or package size and power consumption.

Multimode signaling may reduce crosstalk within a defined collection of conductive lines by utilizing multiconductor transmission line (MTL) theory. An on-die modal encoder may be positioned proximate a transmitter and a corresponding decoder may be positioned proximate a receiver. Binary multimode signaling may move the modal encoder from the transmitter to the receiver or, alternatively, the decoder from the receiver to the transmitter. S-parameter-based multimode signaling may reduce crosstalk on channels having discontinuities. Multimode signaling may also address transmission line FEXT, similar to capacitive-inductive balancing as discussed herein.

A crosstalk reduction mechanism has been developed that may mitigate the effect of near-end crosstalk (NEXT). Coupling between neighboring conductive lines may be utilized to reduce NEXT. Crosstalk reduction by matrix matching may be effective in reducing NEXT in circumstances including, but not limited to, low power interfaces, such as buses between a central processing unit (CPU) die and a memory die or die stack on a common multichip package (MCP). If the receiver ends of the lines are left unterminated, such as to conserve power, NEXT that propagates from the near end to the far end may appear as noise at the receiver, potentially degrading signal integrity. Crosstalk reduction by matrix matching may not utilize the grouping of conductive lines into bundles of predetermined size, in contrast to other techniques discussed above. Additionally, crosstalk reduction by matrix matching may be applied outside of MCPs and without regard to uniform or non-uniform dielectric backgrounds (e.g., in micro strip and strip line structures).

Crosstalk reduction by matrix matching may be applied in either the current or voltage domains. The matrix match may utilize a Thevenin formulation in the voltage domain and a Norton formulation in the current domain. The voltage domain may leave the receiver unmodified while the current domain may leave the transmitter unmodified. Both the voltage and current domains may be utilized advantageously in both data reading and data writing circumstances to reduce NEXT. In circumstances with a conductive line dedicated to writing, the voltage domain may be advantageous while in circumstances with the conductive line dedicated to reading, the current domain may be advantageous.

FIG. 1 is a simplified, cutaway, top profile of a chip package **100** intended to be illustrative of circuit components utilized herein. While a chip package **100** is illustrated, it is to be understood that the circuit and/or the principles described here and throughout this document are applicable to a variety of electronic circuits, including but not limited to printed circuit boards (PCBs), microstrip structures, strip line structures, and the like.

The chip package **100** includes, in an example, a silicon die central processing unit (CPU) **102** communicatively coupled to, in an example, a memory die **104** by way of multiple conductive lines **106**. The conductive lines **106** may be any of a variety of conductive lines capable of and configured to transmit electrical signals from a transmitter **108** to a receiver **110**, such as copper.

The dies **102**, **104** either include a transmitter **108** and a receiver **110** native to the dies **102**, **104**, as illustrated, or may be attached to an off-die transmitter **108** and receiver **110**. The transmitter **108** and receiver **110** themselves variously

include or are attached to a matching module **112**. As will be described and illustrated herein, the matching module **112** may be a part of a single circuit, with the matching modules **112** illustrated in FIG. 1 being illustrated separately for the purposes of clarity of the figure. In various examples, not all matching modules **112** are part of the same matching module circuit. For instance, the matching modules **112** may combine to form two (2) or more separate matching modules **112** as illustrated herein. The matching modules **112** may be configured to reduce near-end crosstalk on the conductive line **106** to which the matching module **112** is coupled. The matching modules **112** may be configured to operate within a multiconductor transmission line system or bus **114**.

As illustrated, the transmitters **108** and receivers **110** illustrated herein variously have or do not have a matching module **112**. The various matching modules **112** may be any of a variety of particular matching modules **112** disclosed herein. In various examples, the matching module **112** is utilized with conductive lines **106** of various lengths. A length of the conductive lines **106** may impact the degree to which crosstalk on the line **106** is variously due to far-end crosstalk (FEXT) and near-end crosstalk (NEXT). In various examples, relatively long conductive lines **106** may be relatively more prone to FEXT and relatively short conductive lines **106** may be relatively more prone to NEXT. In various examples, the matching module **112** is applied on unterminated conductive lines **106** of approximately ten (10) millimeters in length or less. Voltage Signaling—Thevenin Formulation

FIG. 2 is a circuit diagram of a circuit **200** that includes a voltage signaling transmitter **108** having a matching module **112**. For illustrative purposes, the circuit **200** is analyzed based on infinitely long conductive lines **106'** transmitting electrical signals **202**. For infinitely long conductive lines **106'**, a pad voltage vector at die pads **204** of the die **102** is:

$$\bar{V}(0) = \bar{Z}_c(\bar{Z}_c + \bar{Z}_s)^{-1} \bar{V}_s \quad \text{Equation 1}$$

In Equation 1 and herein,  $\bar{V}$  is the pad voltage vector **206** at the die pads **204**,  $\bar{Z}_c$  is the characteristic impedance matrix **208** of the conductive lines **106'** and, in particular, the multiconductor transmission line **114**,  $\bar{V}_s$  is the source voltage vector **210** over the voltage sources **211**, and  $\bar{Z}_s$  is the source impedance matrix **212** of the transmitter **108** and die **102** generally. The current vector **214** may give the current for lines **106'** connected to the die pads **204** and may be:

$$\bar{I}(0) = (\bar{Z}_c + \bar{Z}_s)^{-1} \bar{V}_s \quad \text{Equation 2}$$

Based on Equation 1, by making  $\bar{Z}_s$  proportional to  $\bar{Z}_c$ , the mixing of voltages across conductive lines **106** may be reduced or substantially eliminated.  $\bar{Z}_s$  may be proportional to  $\bar{Z}_c$  when there is a scalar  $x$  such that  $\bar{Z}_s = x * \bar{Z}_c$ . As a result, near-end crosstalk may be reduced or, depending, for instance, on the closeness of the match between  $\bar{Z}_s$  and  $\bar{Z}_c$ , substantially or entirely eliminated.

FIG. 3 is a circuit diagram **300** for a transmitter **108** and conductive line **106**, in an example embodiment. By making  $\bar{Z}_s$  equal or approximately  $\bar{Z}_c$ , i.e., by matching or substantially matching the impedance matrix between the source impedance of the transmitter **108** and die **102** generally and the characteristic impedance of the multiconductor transmission line **114**, reflections from the unterminated receiver **110** may be suppressed or substantially suppressed by absorption at the transmitter **108**. Thus, for a multiconductor transmission line **114** with negligible modal skew, such as may arise from a relatively short conductive line **106** having a micro strip or a conductive line with substantially transverse electromagnetic (TEM) wave propagation such as a strip line, crosstalk may be reduced or substantially eliminated.

For multiconductor transmission lines **114** having conductive lines **106** arranged in a substantially co-planar fashion the characteristic admittance matrix  $\bar{Y}_c = \bar{Z}_c^{-1}$  may be nearly tridiagonal. Thus, matrix matching as disclosed herein may be accomplished with a similarly tridiagonal  $\bar{Y}_s = \bar{Z}_s^{-1}$ .

The transmitter **108** includes resistance to ground **302**  $R_g$  and coupling resistance **304**  $R_c$ . In an example  $R_g$  is approximately thirty (30) Ohms and  $R_c$  is approximately two hundred twenty-five (225) Ohms.  $R_g$  and  $R_c$  may be part of a matching network with a modified source admittance matrix **306** of:

$$\bar{Y}_s' = (\bar{Y}_c - \text{diag}\{j\omega_0 C_p\})^{-1} - \text{diag}\{R_g\}^{-1} \quad \text{Equation 3}$$

In Equation 3,  $\omega_0$  is a fundamental angular frequency for a targeted signaling rate (wherein the fundamental frequency  $f_0$  is  $\omega_0/2\pi$  and the signaling rate is  $2f_0$ ) which may allow for improved matrix matching in the presence of finite source resistance **308**  $R_s$  (e.g., from a non-ideal voltage source) and parasitic pad capacitance **310**  $C_p$  on the die pads **204**. In an example,  $C_p$  is approximately 0.5 picofarads. Equation 3 may, in various examples, be utilized to calculate initial estimates for  $R_g$  and  $R_c$ . The estimates may be refined by numerical optimization or other method to maximize various metrics, such as eye height at the receiver **110**.

In various examples, eye height is the vertical opening of the “eye” of an eye diagram. An eye diagram may display received waveforms as voltage vs. time by overlaying the waveforms for multiple bit time intervals on top of each other. The eye height may be a measure of noise in the received waveforms, for example due to crosstalk. A sufficiently large eye height may enable a receiver to distinguish a “1” from “0” by comparing a received voltage against a reference voltage.

In various examples, the voltage sensing examples using a Thevenin formulation may produce a matrix matching network in the transmitter or receiver that introduces resistive coupling elements **304**  $R_c$  between neighboring conductive lines **106**, presenting a tridiagonal admittance matrix, i.e., an admittance matrix with zero or essentially zero admittance for all matrix elements except on its diagonal and the two first sub-diagonals. In various examples, voltage sensing examples using a Thevenin formulation may produce voltage sources **312** connected between the matching module **112** and the die pads **204**, in contrast to voltage sources connected between ground and the die pads, i.e., “floating” voltage sources. In various examples, voltage sensing examples using a Thevenin formulation may utilize conductive lines **106** and multiconductor transmission lines **114** that are not predefined with respect to one another, as in multimode signaling, but which rather may operate inherently with respect to neighboring conductive lines **106**.

Current Signaling—Norton Formulation

FIG. 4 is a circuit diagram of a circuit **400** that includes a current signaling transmitter **108** having a matching module **401**. For illustrative purposes, the circuit **400** is analyzed based on infinitely long conductive lines **106'** transmitting electrical signals **402**. For infinitely long conductive lines **106'**, a pad voltage vector **403** at die pads **204** of the die **102** is:

$$\bar{V}(0) = (\bar{Y}_c + \bar{Y}_s)^{-1} \bar{I}_s \quad \text{Equation 4}$$

In Equation 4,  $\bar{I}_s$  is the vector of current sources **404** (e.g., electrical signals). The current vector **406** at the die pads **204** is:

$$\bar{I}(0) = \bar{Y}_c(\bar{Y}_c + \bar{Y}_s)^{-1} \bar{I}_s \quad \text{Equation 5}$$

Based on Equation 5, by making  $\bar{Y}_s$  proportional to  $\bar{Y}_c$ , currents may not be “mixed” between conductive lines **106** and such lines may be free or substantially free of current



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crosstalk. Where conductive lines **106** are of finite length with an unterminated receiver **110**, the multiconductor transmission line **114** currents may be received and, in various examples, reflected by the receiver **110** without or substantially without crosstalk between the neighboring conductive lines **106** of the multiconductor transmission line **114**. By making  $\bar{Y}_s$  equal or approximately equal to  $\bar{Y}_c$ , i.e., by matching or substantially matching the impedance matrix between the source impedance matrix of the transmitter **108** and die **102** generally and the characteristic impedance matrix of the multiconductor transmission line **114**, reflections from the unterminated receiver **110** may be suppressed or substantially suppressed by absorption at the transmitter **108**. Thus, for a multiconductor transmission line **114** with negligible modal skew, such as may arise from a relatively short conductive line **106** having a micro strip or a conductive line with substantially transverse electromagnetic (TEM) wave propagation such as a strip line, crosstalk may be reduced or substantially eliminated.

FIG. **5** is a circuit diagram of a matching module **500** for a receiver **110** tapping scheme for Norton formulation-based matrix matching. The matching module **500** may be a tapping circuit. It is to be recognized and understood that, while various examples of matching modules generally may incorporate resistors, the term matching module as used herein may incorporate, for instance, what is illustrated as the matching module **500**.

Open lines at the receiver **110** may make incoming electrical current unobservable or comparatively difficult to observe. Accordingly, the electrical signals on the conductive lines **106** may be reconstructed from observed voltages by a mathematical operation, such as multiplication, with the characteristic admittance matrix  $\bar{Y}_c$ , which may be approximated as tridiagonal, as discussed above. A weighted summation using an adder **502** and scaling circuits **503** to scale voltages on certain conductive lines **106** based on a tapping coefficient  $k_{tap}$  as the ratio of off-diagonal admittance to admittance on the diagonal of the characteristic admittance matrix  $\bar{Y}_c$  can be used. Note that  $k_{tap}$  may be less than zero (0) where the off-diagonal conductances in the characteristic admittance matrix  $\bar{Y}_c$  are negative.

As illustrated, the output voltage  $V'_k$  is:

$$V'_k = V_k + k_{tap} V_{k+1} + k_{tap} V_{k-1} \quad \text{Equation 6}$$

In equation 6,  $V_k$ ,  $V_{k+1}$ , and  $V_{k-1}$  are voltages on adjacent conductive lines **106A**, **106B**, **106C**, respectively. Such lines are physically adjacent to one another on a layout of the chip package **100**. The output voltage  $V'_k$  at **504** may also be free or substantially free of crosstalk. As such, data in the electrical signals may be measured using voltage rather than current. Alternatively or additionally, the tapping operation may be a component of the transmitter **108**. The signals to be transmitted may be combined with scaled copies of the signals to be transmitted on the nearest neighbor conductive lines **106**, where the scaling is accomplished by multiplication with the tapping coefficient  $k_{tap}$ .

FIG. **6** is a circuit diagram of a circuit **600** including a voltage source **602** for a voltage source **108** (not pictured). The voltage source **602** may be adapted from the circuit **400** of FIG. **4**. The voltage source **602** includes making the source resistance **604**  $R_s$  equal to the ground resistance  $R_g$  as disclosed herein. The voltage source **602** further includes a voltage source **606** based on the product of the current source  $I_s$  as disclosed herein and the ground resistance  $R_g$ .

In various examples, the current signaling Norton formulation may provide for a matrix matching network in the transmitter **108** that introduces resistive coupling **608**  $R_c$

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between neighboring conductive lines **106**, presenting a tridiagonal admittance matrix. In various examples, the current signaling Norton formulation may provide for adding of electrical signals from neighboring conductive lines **106**, such as from received voltages, scaled by a tapping coefficient  $k_{tap}$  to the neighboring signals at one or both of the receiver **110** or the transmitter **108**. In various examples, the current signaling Norton formulation may provide for unbundled conductive lines **106**.

FIG. **7** is a flowchart for transmitting electrical signals along a plurality of conductive lines.

At **700**, electrical signals are generated with a transmitter.

At **702**, the electrical signals are transmitted along a plurality of conductive lines between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled, the plurality of conductive lines being expressible as a characteristic impedance matrix. In an example, a source impedance of the transmitter is expressible as a source impedance matrix based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, the source impedance matrix being substantially proportional to the characteristic impedance matrix. In an example, the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

In an example, the resistive coupling comprises resistive coupling elements, wherein each one of the resistive coupling elements is coupled between individual ones of the plurality of conductive lines. In an example, each of the resistive coupling elements corresponds to one pair of the plurality of conductive lines and each pair of the plurality of conductive lines corresponds to one of the resistive coupling elements. In an example, the resistive coupling elements form a tridiagonal admittance matrix. In an example, the plurality of conductive lines are not terminated. In an example, the transmitter comprises a plurality of voltage sources individually coupled to the resistive coupling and to one of the conductive lines.

At **704**, a current is driven with a plurality of current sources over one of the plurality of conductive lines. In an example, wherein the plurality of conductive lines have a first end coupled to the transmitter and a second end, and further include a receiver coupled to the second end of the plurality of conductive lines.

At **706**, an electrical signal of a first line of the plurality of conductive lines is added with an adder of the receiver with an electrical signal of a second line of the plurality of conductive lines adjacent to the first line. In an example, adding the electrical signal comprises adding each line of the plurality of conductive lines adjacent to the first line. In an example, the electrical signal of each line of the plurality of conductive lines adjacent to the first line is scaled, with a scaling circuit, based on a tapping coefficient.

An example of an electronic device using semiconductor chips as described in the present disclosure is included to show an example of a higher level device application for the present invention. FIG. **8** is a block diagram of an electronic device **800** that can incorporate at least one package, such as a package **100** or other package described in examples herein. The electronic device **800** is merely one example of an electronic system in which embodiments of the present invention can be used. Examples of electronic devices **800** include, but are not limited to personal computers, tablet computers, mobile telephones, personal data assistants, MP3 or other digital music players, etc. In this example, the electronic device **800** comprises a data processing system that includes a system bus **802** to couple the various components of the

system. The system bus **802** provides communications links among the various components of the electronic device **800** and can be implemented as a single bus, as a combination of busses, or in any other suitable manner.

An electronic assembly **810** is coupled to the system bus **802**. The electronic assembly **810** can include any circuit or combination of circuits. In one embodiment, the electronic assembly **810** includes a processor **812** which can be of any type. As used herein, "processor" means any type of computational circuit, such as but not limited to a microprocessor, a microcontroller, a complex instruction set computing (CISC) microprocessor, a reduced instruction set computing (RISC) microprocessor, a very long instruction word (VLIW) microprocessor, a graphics processor, a digital signal processor (DSP), multiple core processor, or any other type of processor or processing circuit.

Other types of circuits that can be included in the electronic assembly **810** are a custom circuit, an application-specific integrated circuit (ASIC), or the like, such as, for example, one or more circuits (such as a communications circuit **814**) for use in wireless devices like mobile telephones, pagers, personal data assistants, portable computers, two-way radios, and similar electronic systems. The IC can perform any other type of function.

The electronic device **800** can also include an external memory **820**, which in turn can include one or more memory elements suitable to the particular application, such as a main memory **822** in the form of random access memory (RAM), one or more hard drives **824**, and/or one or more drives that handle removable media **826** such as compact disks (CD), digital video disk (DVD), and the like.

The electronic device **800** can also include a display device **816**, one or more speakers **818**, and a keyboard and/or controller **830**, which can include a mouse, trackball, touch screen, voice-recognition device, or any other device that permits a system user to input information into and receive information from the electronic device **800**.

#### ADDITIONAL EXAMPLES

Example 1 includes a circuit, device, or system that includes a plurality of conductive lines configured to transmit electrical signals between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled, and a transmitter, configured to generate the electrical signals, the transmitter including a source impedance based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, a source impedance matrix of the source impedance being substantially proportional to the characteristic impedance matrix of the plurality of conductive lines.

Example 2 includes the subject matter of Example 1 and further includes that the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

Example 3 includes the subject matter of any one or more of Examples 1 and 2 and further includes that the resistive coupling comprises resistive coupling elements, wherein each one of the resistive coupling elements is coupled between individual ones of the plurality of conductive lines.

Example 4 includes the subject matter of any one or more of Examples 1-3 and further includes that each of the resistive coupling elements corresponds to one pair of the plurality of conductive lines and each pair of the plurality of conductive lines corresponds to one of the resistive coupling elements.

Example 5 includes the subject matter of any one or more of Examples 1-4 and further includes that the resistive coupling elements form a tridiagonal admittance matrix.

Example 6 includes the subject matter of any one or more of Examples 1-5 and further includes that the plurality of conductive lines are not terminated.

Example 7 includes the subject matter of any one or more of Examples 1-6 and further includes that the transmitter comprises a plurality of voltage sources individually coupled to the resistive coupling and to one of the conductive lines.

Example 8 includes the subject matter of any one or more of Examples 1-7 and further includes a plurality of current sources, each current source being configured to drive a current over one of the plurality of conductive lines.

Example 9 includes the subject matter of any one or more of Examples 1-8 and further includes that the plurality of conductive lines have a first end coupled to the transmitter and a second end, and further includes a receiver coupled to the second end of the plurality of conductive lines, wherein the receiver comprises an adder configured to add an electrical signal of a first line of the plurality of conductive lines with an electrical signal of a second line of the plurality of conductive lines adjacent to the first line.

Example 10 includes the subject matter of any one or more of Examples 1-9 and further includes that the adder is configured to add the electrical signal of each line of the plurality of conductive lines adjacent to the first line.

Example 11 includes the subject matter of any one or more of Examples 1-10 and further includes a scaling circuit configured to scale the electrical signal of each line of the plurality of conductive lines adjacent to the first line based on a tapping coefficient.

Example 12 includes the subject matter of any one or more of Examples 1-11 and further includes that the conductive lines are less than approximately ten (10) millimeters long.

Example 13 includes a method that may be performed on a circuit, device or system and includes generating, with a transmitter, electrical signals, and transmitting the electrical signals along a plurality of conductive lines between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled. A source impedance of the transmitter is based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, a source impedance matrix of the source impedance being substantially proportional to a characteristic impedance matrix of the plurality of conductive lines.

Example 14 includes the subject matter of Example 13 and further includes that the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

Example 15 includes the subject matter of any one or more of Examples 13 and 14 and further includes that the resistive coupling comprises resistive coupling elements, wherein each one of the resistive coupling elements is coupled between individual ones of the plurality of conductive lines.

Example 16 includes the subject matter of any one or more of Examples 13-15 and further includes that each of the resistive coupling elements corresponds to one pair of the plurality of conductive lines and each pair of the plurality of conductive lines corresponds to one of the resistive coupling elements.

Example 17 includes the subject matter of any one or more of Examples 13-16 and further includes that the resistive coupling elements form a tridiagonal admittance matrix.

Example 18 includes the subject matter of any one or more of Examples 13-17 and further includes that the plurality of conductive lines are not terminated.

Example 19 includes the subject matter of any one or more of Examples 13-18 and further includes that the transmitter comprises a plurality of voltage sources individually coupled to the resistive coupling and to one of the conductive lines.

Example 20 includes the subject matter of any one or more of Examples 13-19 and further includes driving, with a plurality of current sources, a current over one of the plurality of conductive lines.

Example 21 includes the subject matter of any one or more of Examples 13-20 and further includes that the plurality of conductive lines have a first end coupled to the transmitter and a second end, and further includes a receiver coupled to the second end of the plurality of conductive lines, further including adding, with an adder of the receiver, an electrical signal of a first line of the plurality of conductive lines with an electrical signal of a second line of the plurality of conductive lines adjacent to the first line.

Example 22 includes the subject matter of any one or more of Examples 13-21 and further includes that adding the electrical signal comprises adding each line of the plurality of conductive lines adjacent to the first line.

Example 23 includes the subject matter of any one or more of Examples 13-22 and further includes scaling, with a scaling circuit, the electrical signal of each line of the plurality of conductive lines adjacent to the first line based on a tapping coefficient.

Example 24 includes the subject matter of any one or more of Examples 13-23 and further includes that the conductive lines are less than approximately ten (10) millimeters long.

Each of these non-limiting examples can stand on its own, or can be combined with one or more of the other examples in any permutation or combination.

The above detailed description includes references to the accompanying drawings, which form a part of the detailed description. The drawings show, by way of illustration, specific embodiments in which the invention can be practiced. These embodiments are also referred to herein as “examples.” Such examples can include elements in addition to those shown or described. However, the present inventors also contemplate examples in which only those elements shown or described are provided. Moreover, the present inventors also contemplate examples using any combination or permutation of those elements shown or described (or one or more aspects thereof), either with respect to a particular example (or one or more aspects thereof), or with respect to other examples (or one or more aspects thereof) shown or described herein.

In this document, the terms “a” or “an” are used, as is common in patent documents, to include one or more than one, independent of any other instances or usages of “at least one” or “one or more.” In this document, the term “or” is used to refer to a nonexclusive or, such that “A or B” includes “A but not B,” “B but not A,” and “A and B,” unless otherwise indicated. In this document, the terms “including” and “in which” are used as the plain-English equivalents of the respective terms “comprising” and “wherein.” Also, in the following claims, the terms “including” and “comprising” are open-ended, that is, a system, device, article, composition, formulation, or process that includes elements in addition to those listed after such a term in a claim are still deemed to fall within the scope of that claim. Moreover, in the following claims, the terms “first,” “second,” and “third,” etc. are used merely as labels, and are not intended to impose numerical requirements on their objects.

The above description is intended to be illustrative, and not restrictive. For example, the above-described examples (or one or more aspects thereof) may be used in combination with each other. Other embodiments can be used, such as by one of ordinary skill in the art upon reviewing the above description. The Abstract is provided to comply with 37 C.F.R. §1.72(b), to allow the reader to quickly ascertain the nature of the technical disclosure. It is submitted with the understanding that it will not be used to interpret or limit the scope or meaning of the claims. Also, in the above Detailed Description, various features may be grouped together to streamline the disclosure. This should not be interpreted as intending that an unclaimed disclosed feature is essential to any claim. Rather, inventive subject matter may lie in less than all features of a particular disclosed embodiment. Thus, the following claims are hereby incorporated into the Detailed Description, with each claim standing on its own as a separate embodiment, and it is contemplated that such embodiments can be combined with each other in various combinations or permutations. The scope of the invention should be determined with reference to the appended claims, along with the full scope of equivalents to which such claims are entitled.

What is claimed is:

1. An electrical circuit, comprising:

a plurality of conductive lines configured to transmit electrical signals between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled;

a transmitter, configured to generate the electrical signals, the transmitter including a source impedance based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, a source impedance matrix of the source impedance being substantially proportional to a characteristic impedance matrix of the plurality of conductive lines;

wherein the resistive coupling comprises resistive coupling elements, wherein each one of the resistive coupling elements is coupled between individual ones of the plurality of conductive lines;

wherein each of the resistive coupling elements corresponds to one pair of the plurality of conductive lines and each pair of the plurality of conductive lines corresponds to one of the resistive coupling elements; and wherein the resistive coupling elements form a tridiagonal admittance matrix.

2. The electrical circuit of claim 1, wherein the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

3. The electrical circuit of claim 1, wherein the plurality of conductive lines are not terminated.

4. The electrical circuit of claim 1, wherein the transmitter comprises a plurality of voltage sources individually coupled to the resistive coupling and to one of the conductive lines.

5. The electrical circuit of claim 1, further comprising a plurality of current sources, each current source being configured to drive a current over one of the plurality of conductive lines.

6. An electrical circuit, comprising:

a plurality of conductive lines configured to transmit electrical signals between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled;

a transmitter, configured to generate the electrical signals, the transmitter including a source impedance based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, a source impedance matrix of the source impedance being substantially

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proportional to a characteristic impedance matrix of the plurality of conductive lines; and  
 a plurality of current sources each current source being configured to drive a current over one of the plurality of conductive lines;

wherein the plurality of conductive lines have a first end coupled to the transmitter and a second end, and further comprising a receiver coupled to the second end of the plurality of conductive lines, wherein the receiver comprises an adder configured to add an electrical signal of a first line of the plurality of conductive lines with an electrical signal of a second line of the plurality of conductive lines adjacent to the first line.

7. The electrical circuit of claim 6, wherein the adder is configured to add the electrical signal of each line of the plurality of conductive lines adjacent to the first line.

8. The electrical circuit of claim 7, further comprising a scaling circuit configured to scale the electrical signal of each line of the plurality of conductive lines adjacent to the first line based on a tapping coefficient.

9. The electrical circuit of claim 6, wherein the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

10. A method, comprising:

generating, with a transmitter, electrical signals; and  
 transmitting the electrical signals along a plurality of conductive lines between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled;

wherein a source impedance of the transmitter is based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, a source impedance matrix of the source impedance being substantially proportional to the characteristic impedance matrix of the plurality of conductive lines;

wherein a resistive coupling comprises resistive coupling elements, wherein each one of the resistive coupling elements is coupled between individual ones of the plurality of conductive lines;

wherein each of the resistive coupling elements corresponds to one pair of the plurality of conductive lines and each pair of the plurality of conductive lines corresponds to one of the resistive coupling elements; and  
 wherein the resistive coupling elements form a tridiagonal admittance matrix.

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11. The method of claim 10, wherein the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

12. The method of claim 10, wherein the plurality of conductive lines are not terminated.

13. The method of claim 10, wherein the transmitter comprises a plurality of voltage sources individually coupled to the resistive coupling and to one of the conductive lines.

14. The method of claim 10, further comprising driving, with a plurality of current sources, a current over one of the plurality of conductive lines.

15. A method, comprising:

generating, with a transmitter, electrical signals;

transmitting the electrical signals along a plurality of conductive lines between a first electronic component and a second electronic component between which the plurality of conductive lines are coupled; and

driving, with a plurality of current sources, a current over one of the plurality of conductive lines

wherein a source impedance of the transmitter is based, at least in part, on a resistive coupling between individual ones of the plurality of conductive lines, a source impedance matrix of the source impedance being substantially proportional to the characteristic impedance matrix of the plurality of conductive lines;

wherein the plurality of conductive lines have a first end coupled to the transmitter and a second end, and further comprising a receiver coupled to the second end of the plurality of conductive lines, further comprising adding, with an adder of the receiver, an electrical signal of a first line of the plurality of conductive lines with an electrical signal of a second line of the plurality of conductive lines adjacent to the first line.

16. The method of claim 15, wherein adding the electrical signal comprises adding each line of the plurality of conductive lines adjacent to the first line.

17. The method of claim 16, further comprising scaling, with a scaling circuit, the electrical signal of each line of the plurality of conductive lines adjacent to the first line based on a tapping coefficient.

18. The method of claim 15, wherein the characteristic impedance matrix is approximately equal to the source impedance matrix of the transmitter.

\* \* \* \* \*

UNITED STATES PATENT AND TRADEMARK OFFICE  
**CERTIFICATE OF CORRECTION**

PATENT NO. : 9,093,990 B2  
APPLICATION NO. : 14/031438  
DATED : July 28, 2015  
INVENTOR(S) : Henning Braunsch

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:


In the claims

In column 11, line 3, in Claim 6, delete “sources” and insert --sources--, therefor

In column 11, line 36, in Claim 10, delete “e” and insert --the--, therefor

In column 12, line 19, in Claim 15, after “lines”, insert --;--, therefor

Signed and Sealed this  
Seventh Day of June, 2016

A handwritten signature in black ink, reading "Michelle K. Lee". The signature is fluid and cursive, with the first letters of each name being capitalized and prominent.

Michelle K. Lee  
*Director of the United States Patent and Trademark Office*